

Cadmium complex possessing simultaneously silanethiolato- and dithiocarbamato-ligands. A novel single-source precursor of cadmium sulfide

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Abstract Thermal decomposition of suitable coordination compounds may be used as efficient route for fabrication of semiconducting layers. A new potential CdS precursor—a cadmium complex with all-sulfur Cd-coordination sphere $[\text{Cd}\{\mu\text{-SSi}(\text{O}^t\text{Bu})_3\}(\text{S}_2\text{CNC}_4\text{H}_8)]_2$ **1**—has been prepared, and its properties are investigated. The complex was obtained in the reaction between dimeric bis(tri-*tert*-butoxysilanethiolato)cadmium(II) $[\text{Cd}\{\text{SSi}(\text{O}^t\text{Bu})_3\}_2]_2$ and ammonium *N,N*-tetramethylene-dithiocarbamate and characterized by spectral methods (IR, UV–Vis, MS, and NMR). X-ray structure analysis revealed the complex as molecular and dimeric in

solid state with each of chelating dithiocarbamate ligands bonded to one Cd center and sulfur atoms from two tri-*tert*-butoxysilanethiolato ligands bridging metallic centers and thus completing the CdS_4 coordination sphere. Thin film of the precursor prepared on SiO_2 substrates via spin-coating technique was analyzed by AFM. Its decomposition was studied by thermal analysis methods (TG, DSC, and TG-FTIR). After melting at 227 °C, $[\text{Cd}\{\mu\text{-SSi}(\text{O}^t\text{Bu})_3\}(\text{S}_2\text{CNC}_4\text{H}_8)]_2$ undergoes endothermic decomposition leading to CdS as the only solid product further identified by XRD, EDS, FIR as hexagonal CdS form. Its morphology is characteristic and may be described as “micro-noodles”.

Keywords Cadmium sulfide precursor · Cadmium (II) complexes · Dithiocarbamate · Silanethiolate · Structure · Thermal analysis

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Introduction

The chemistry of complexes with S-donor ligands has recently gained renewed attention because of their use as efficient precursors of metal sulfides [1]. A special attention is paid for semiconductor nanocrystals due to their unique electronic and optical properties, and thus for their technological potential. CdS belongs to the II–VI compound family and is a well-studied semiconductor with a direct band gap of 2.42 eV and widespread applications, e.g., in solar cells, optical detectors, and optoelectronic devices [2]. It has also been a subject of intensive research not only because of its useful band gap but also high absorption coefficient, conversion efficiency, stability, and low cost [3]. CdS thin films are a desirable and the most commonly used window materials for high-efficiency polycrystalline thin-film photovoltaic devices [4, 5].

CdS layers can be obtained using the methods such as vacuum evaporation, chemical vapor deposition, spray pyrolysis, cathodic pulverization, sputtering, sintering, or screen printing [6]. Among these methods, pyrolysis is a simple, convenient, and low-cost technique for a large-area production. Although the obtained films are polycrystalline, stable, and uniform, still many efforts are devoted to the preparation of systems with the desired properties. It can be achieved, e.g., by controlling the size, morphology, and crystallinity of the products.

During the last two decades, the studies of metallic complexes with S-donors showed a progressive development. Species such as thiolates, dithiocarbamates (*dtc*) [7–11], dithiophosphinates [12], xanthates [13–15], and other compounds [16] have been successfully used to obtain respective sulfides. So far, dithiocarbamates remain most widely used for this purpose with *dtc* being undoubtedly the one of the most explored *S,S'*-chelate systems. We found it remarkable that despite vast knowledge of complexes with S-donor ligands, still there is very little known about the preparation, properties, and usage of systems containing simultaneously two different S-donors. For compounds with $^{-}S_2CNR_2$ ligands we found that only one paper—concerning tin complexes with dithiocarbamate- and thiolato-rests ligating the same metallic centre [17]—falls within this subject.

We have recently reported synthesis of a first molecular Cd(II) trialkoxysilanethiolate bearing simultaneously *dtc* ligand [18] together with some studies concerning its thermal decomposition [19, 20]. We regard molecular silanethiolates as an alternative to conventional, much more explored and usually polymeric thiolates. Synthesis of heteroleptic complexes with this type of ligands and sulfur-rich metal coordination sphere seems to be a promising route to the preparation of species of greater volatility and desirable decomposition pathway.

Herein, we report on the preparation and properties of a new compound—a neutral, binuclear complex $[Cd\{\mu\text{-SSi}(\text{O}Bu^t)_3\}(S_2CNC_4H_8)]_2$ **1** together with the data concerning its thermal decomposition and characterization of thus obtained CdS.

Experimental

Materials

All solvents were dried according to common procedures, degassed, and distilled prior to use. Dimeric bis(tri-*tert*-butoxysilanethiolato)cadmium(II) complex was prepared as described elsewhere [21]. Ammonium *N,N*-tetramethylenedithiocarbamate, $C_4H_8NCS_2NH_4$ (Fluka), and

other commercially available chemicals were used as received.

Synthesis of complexes

Ammonium *N,N*-tetramethylenedithiocarbamate (0.049 g) was dissolved in 7 cm³ of distilled water and mixed with a solution of cadmium silanethiolate (0.135 g) dissolved in 10 cm³ of hot toluene. The content of the reaction flask was shaken vigorously for ca. 4 h using Universal Shaker 327 (Premed). Organic layer was separated, washed three times with distilled water, and dried over $MgSO_4$ (Chempur). The resulting solution was evaporated to dryness, and the solid residue was recrystallized from toluene giving crystals of **1**. Monocrystals of compound **1** of quality sufficient for X-ray measurements were obtained by dissolution of the complex in toluene at room temperature, followed by slow crystallization.

Yield (**1**) 75 %, Anal. Found: C, 37.92; S, 17.72; H, 6.70; N, 2.71 %. Calc. for $C_{34}H_{70}O_6N_2S_6Si_2Cd$ ($M_r = 1076,33$) C, 37.94; S, 17.87; H, 6.55; N, 2.60 %. IR (KBr pellet, cm^{-1}): $\nu(C-O)$ 1179; $\nu(Si-O)$ 1072, 1047, 1028, 1002; $\nu(Si-S)$ 691, 633, 530. FIR (PS, cm^{-1}): 243 (Cd-S). UV-Vis (CH_3OH solution, nm): 205, 252, 285. 1H NMR ($CDCl_3$), δ (ppm): 1.43 (s, 27H, CH_3 (Bu^t)), 2.08–2.13 (qui, 4H, $CH_2CH_2CH_2$), 3.7–3.78 (t, 4H, *N-CH*₂). MS, *m/e*: 539 [$Cd\{SSi(OBu^t)_3\}(S_2CNC_4H_8)$], 265(100) [$HSSi(OBu)_3-Me$], 209(31) [(265)- C_4H_8], 153(93) [(209)- C_4H_8], 95(75) [$HSSi(OH)_2$], 57(98) [C_4H_9].

Physical measurements

Elemental analysis

Elemental analysis of carbon, hydrogen, nitrogen, and sulfur was carried out by CHNS Euro-EA model 3018 (EuroVector) microanalyzer.

Spectroscopic measurements

IR spectra were recorded on a FTIR Mattson Genesis II Gold, externally controlled by WinFirst software. Spectra were registered in solid state (KBr pellet) and in solution (CCl_4 , KBr cuvette, 0.248 mm) in the range of 4000–400 cm^{-1} . FIR spectra were recorded using BRUKER spectrometer IFS66. Measurements were made in polystyrene film with 0.12 cm^{-1} resolution in the range of 700–4.0 cm^{-1} . UV spectra were recorded using Unicam UV 300 spectrometer externally controlled by Vision 32 software. Quartz cuvettes and methanol as solvent were used.

^1H NMR spectra were registered with Gemini 200 (200 MHz) spectrometer (Varian) in CDCl_3 , and mass spectra were recorded using Finnigan Mat 95 (EI 75 eV).

Thermal analysis

Thermogravimetry coupled with IR was carried out in argon flow (purge: 90 mL min^{-1} and protective: 65 mL min^{-1}) using Netzsch Thermobalance TG 209 coupled with a Bruker IFS66 FTIR spectrometer. Approximately, 8–10 mg samples were taken in Al_2O_3 crucibles. The experiments were carried out in the temperature range of 20–500 °C, for the heating rates of 2, 5, and 10 K min^{-1} . The volatiles evolving from the heated sample were transported to the spectrometer chamber via thermostated pipe in a stream of argon.

Differential Scanning Calorimetry measurements were performed with the DSC 7 (Perkin–Elmer). Samples of ca. 5 mg, encapsulated in aluminum containers, were melted and recrystallized at 10 °C min^{-1} rate in an inert gas atmosphere (N_2).

Spin-coating and characterization of films

Thin films of the complex were prepared on silicon oxide substrates via spin-coating (3000 RPM, 120 s.) using clear solutions of the complexes and the concentration of 1 mg mL^{-1} in toluene. Tapping mode AFM (Dimension 3100 Digital Instruments with Nanoscope IVa) was used to characterize the samples in terms of morphology.

Deposition of the complex

Samples of **1** were thermally treated in a furnace using a heating rate of 5 K min^{-1} . The obtained yellow solid residue was further investigated by XRD, EDS, and SEM techniques.

Electron microscopy

The SEM experiments were performed using a combined Philips-FEI XL 30 ESEM system, at an acceleration voltage of 30 kV. The digitized images were recorded at different magnifications.

EDS, XPS

The EDS measurements were also performed using Philips ESEM XL 30 equipped with an energy-dispersive X-ray diffractometer, EDX/EDAX Sapphire[®]. XPS measurements were performed using a Kratos AXIS ULTRA instrument with a monochromated $\text{Al K}\alpha$ X-ray source (1486.6 eV) operated at 15 mA emission current and 10 kV anode potential. The instrument was used in FAT (fixed analyzer transmission) mode with a pass energy of 80 eV for wide scans and a pass energy 20 eV for high-resolution scans.

Table 1 Selected crystal data for $[\text{Cd}\{\mu\text{-SSi}(\text{OBU}^t)_3\}(\text{S}_2\text{CNC}_4\text{H}_8)]_2$ **1**

Empirical formula	$\text{C}_{34}\text{H}_{70}\text{O}_6\text{N}_4\text{S}_6\text{Si}_2\text{Cd}_2$
Formula mass/ g mol^{-1}	1076.26
Crystal system	monoclinic
Space group	$C2/c$
Crystal shape/colour	Plate/colorless
Crystal size/mm	$0.24 \times 0.13 \times 0.03$
Unit cell dimensions	
$a/\text{Å}$	22.487(2)
$b/\text{Å}$	11.895(1)
$c/\text{Å}$	19.054(2)
$\beta/^\circ$	94.68(1)
$V/\text{Å}^3$	5079.6(6)
Z	4
$D_{\text{calc}}/\text{g cm}^{-3}$	1.407
Temperature/ $^\circ\text{C}$	22
μ ($\text{MoK}\alpha$)/ mm^{-1}	1.169
θ range	2.84–26
Range of h, k and l	$-27 < h < 27$ $-14 < k < 14$ $-21 < l < 23$
$F(000)$	2224
R_{int}	0.0481
N (refl. total)	4,992
N (refl. observed)	4,770
Criterion of significance	$I > 2\sigma(I)$
N (parameters)	281
S (goodness-of-fit) on F^2	1.131
$R_1, w_2(F^2 > 2\sigma(F^2))$	0.053; 0.1255
$\Delta\rho_{\text{max}}, \Delta\rho_{\text{min}}$ ($e/\text{Å}^3$)	−0.467; 0.864

XRD

The X-ray patterns of the crystalline residues were recorded at room temperature using X'Pert Philips diffractometer (source radiation: $\text{Cu K}\alpha_1$, $\lambda = 0.1546\text{ nm}$, 40 kV, 30 mA). For characterization and qualitative analysis, the results were compared with standard data from the International Centre for Diffraction Data [22].

Crystal structure determination

Suitable single crystal of $[\text{Cd}\{\mu\text{-SSi}(\text{OBU}^t)_3\}(\text{S}_2\text{CNC}_4\text{H}_8)]_2$ was selected and mounted on a quartz capillary with epoxy resin. Experimental intensity data were collected at 295(2) K on a KM4 diffractometer, having goniometer equipped with Sapphire 2 CCD detector (Oxford Diffraction) with monochromated $\text{MoK}\alpha$ radiation ($\lambda = 0.71073\text{ Å}$). Data were collected in four series of 152 frames each, at $\varphi = 0^\circ, 90^\circ, 180^\circ$, and 270° ; ω scan width of 0.75° ; and exposure time of 50 s per frame. The unit cell dimensions, additional

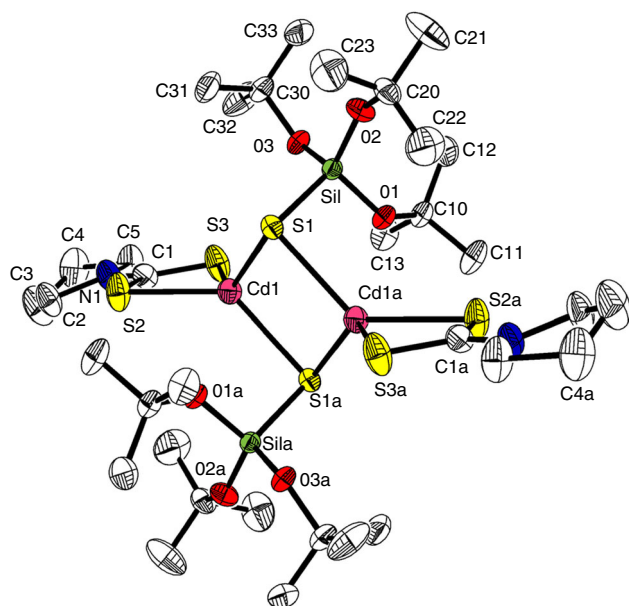


Fig. 1 Crystal and molecular structure of $[\text{Cd}\{\mu\text{-SSi}(\text{OBu}')_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]$ **1**. Thermal ellipsoids 30 %. Carbon atoms C2–C5 are disordered over two positions occupied with probabilities 0.66(3)/0.34(3). For clarity, only 66 % disorder component is shown, and H atoms have been omitted. [Symmetry code: (a) $-x, -y, -z$]. Selected bond lengths (Å): Cd1–S1 2.614(1), Cd1–S1a 2.545(1), Cd1–S2 2.536(2), Cd1–S3 2.599(2), S2–C1 1.718(5), S3–C1 1.707(5), Si1–S1 2.1244(14) and angles (°): Cd1–S1–Cd1a 83.97(3), S1–Cd1–S1a 96.03(3), S1–Cd1–S2 131.46(5), S1a–Cd1–S3 130.51(5), S2–Cd1–S3 70.53(4), S2–C1–S3 120.0(3), Cd1–S1–Si1 93.88(5), Cd1–S2–C1 85.48(2), Cd1–S3–C1 83.71(2)

crystallographic data, and refinement results for the complex are given in Table 1.

The structure was solved by direct methods and refined by least-squares calculation using anisotropic

Fig. 2 AFM surface topography images of thin layer of complex **1** spin-cast on Si

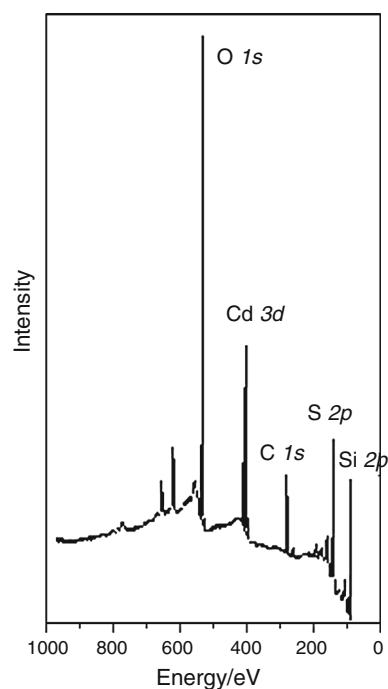
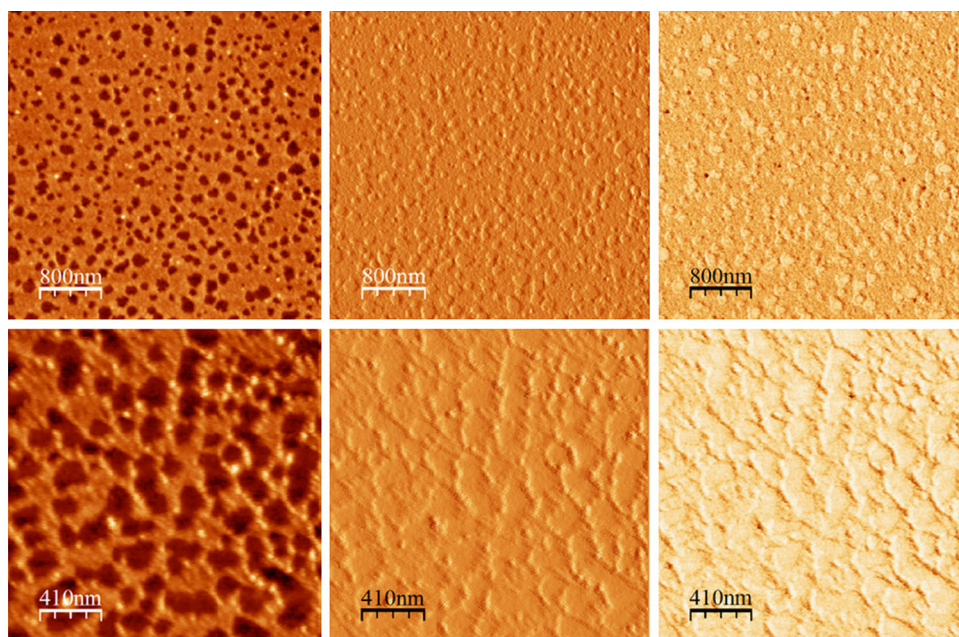


Fig. 3 XPS spectrum of $[\text{Cd}\{\mu\text{-SSi}(\text{OBu}')_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]$ **1**

approximation for non-hydrogen atoms. H atoms were added at ideal positions and refined using the standard riding model. The thiocarbamate ($\text{S}_2\text{CNC}_4\text{H}_8$) group was refined with C2–C5 atoms disordered over two positions occupied with probabilities 0.66(3)/0.34(3).

Data collection and reduction, as well as refinement of unit cell parameters, were performed using CrysAlis CCD and CrysAlis RED [23]. The structure solution and refinement (by full-matrix least-squares against F^2) was

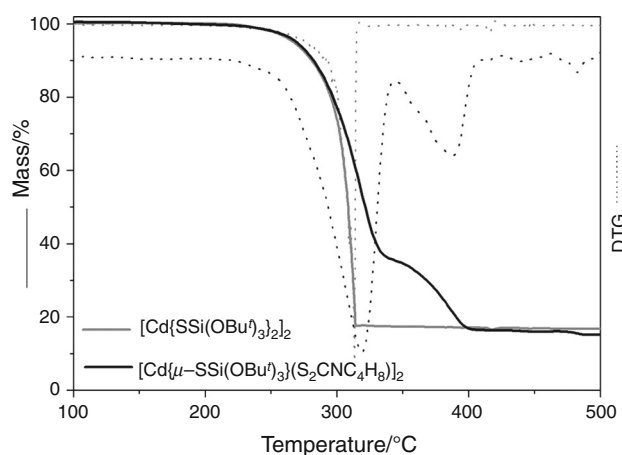


Fig. 4 Thermal decomposition curves of the homoleptic substrate $[\text{Cd}\{\text{SSi}(\text{OBu}^t)_3\}_2]_2$ and heteroleptic $[\text{Cd}\{\mu\text{-SSi}(\text{OBu}^t)_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]_2$ **1** (heating rate 10 K min^{-1})

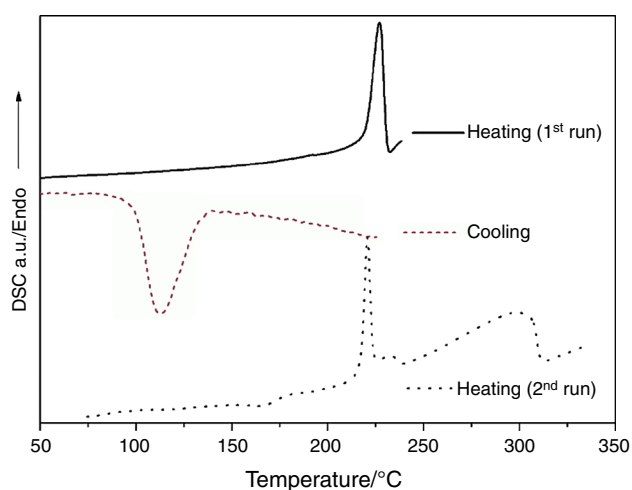
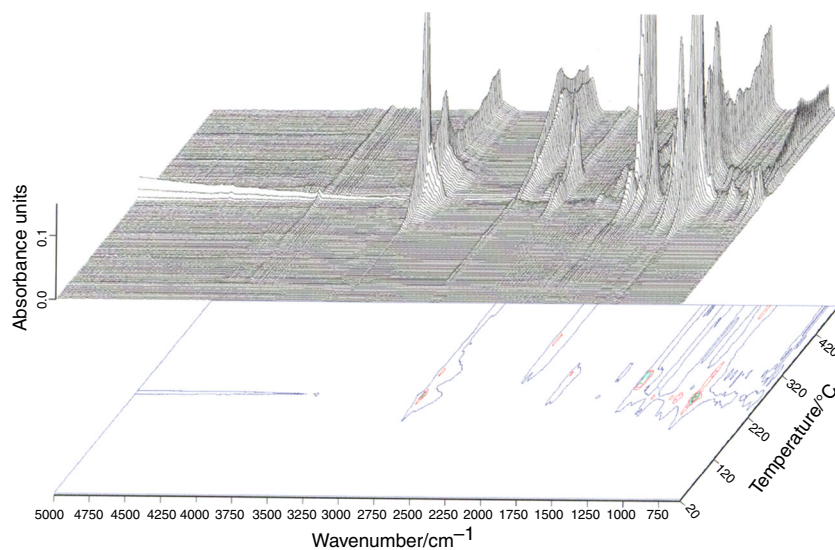


Fig. 5 Differential scanning calorimetry curves recorded for $[\text{Cd}\{\text{SSi}(\text{OBu}^t)_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]_2$ (at the heating rate of 10 K min^{-1})

Fig. 6 3D IR spectra of volatiles evolving during TG analysis in the function of temperature for $[\text{Cd}\{\mu\text{-SSi}(\text{OBu}^t)_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]_2$



performed using WinGX program package (ver.1.80.05, Farrugia 1999) [24].

Results and discussion

In order to obtain complexes that can serve as precursors of respective sulfides, we have focused our attention on the synthesis of compounds with different S-donors (among them one with S–Si bond) ligating to the same metallic center. Our recent investigations [18] have proven that $[\text{Cd}\{\text{SSi}(\text{OBu}^t)_3\}_2]_2$ [21]/ $^{(-)}\text{S}_2\text{CNR}_2(\text{drc})/\text{R}'_4\text{NX}$ reaction system can be used for this purpose. We noted, however, that besides the desired neutral complexes with sulfur-rich kernel, it was also possible to obtain ionic by-

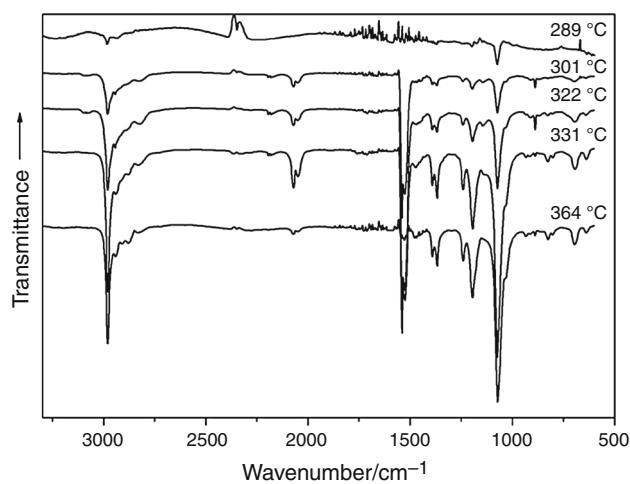
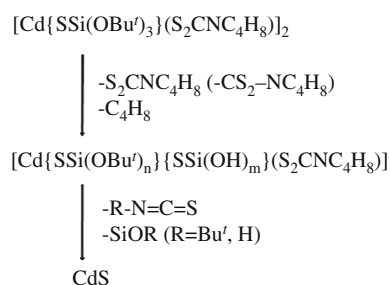


Fig. 7 Selected IR spectra of volatiles evolving during TG analysis of $[\text{Cd}\{\mu\text{-SSi}(\text{OBu}^t)_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]_2$ recorded at several temperatures for the heating rate of 10 K min^{-1}

**Scheme 1** Decomposition scheme**Table 2** TG results for **1** (heating rate of 10 K min⁻¹)

TG range/°C	DTG _{max} /°C	Mass loss obs./%	Mass loss calcd./%
229–334	318.9	64.6	60.3
335–407	388.0	20.5	22.1

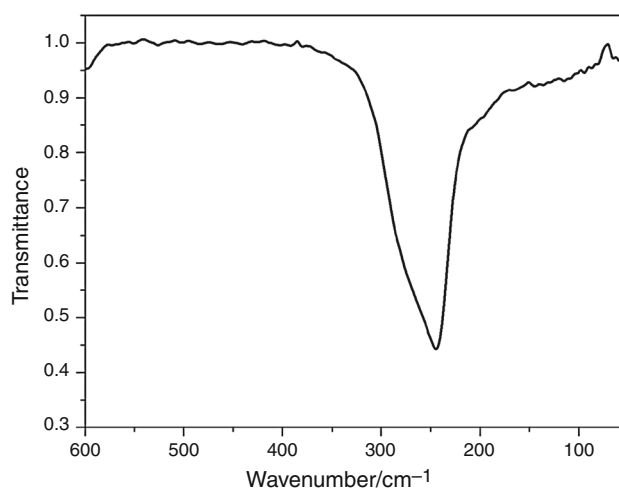
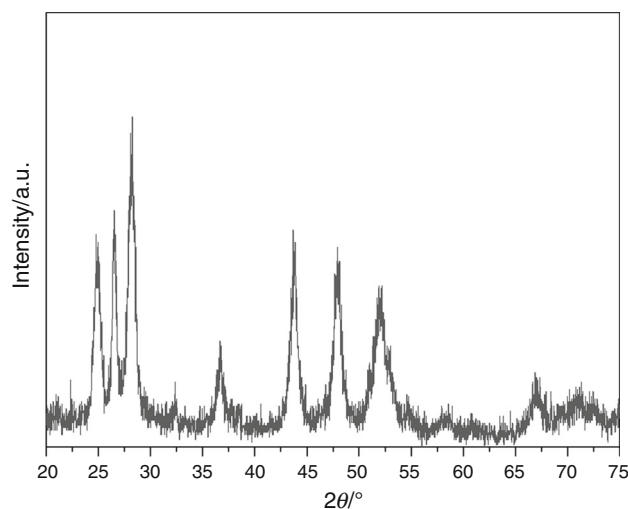
Table 3 DSC results for **1** (the heating rate of 10 K min⁻¹)

Change	<i>T</i> _{max} /°C	Temperature range <i>T</i> _i – <i>T</i> _f /°C	Transferred heat ^a $\Delta H/J \text{ g}^{-1}$	Molar heat of phase transition/ kJ mol ⁻¹
Melting	227	220–232	50.4	54.25
Decomposition	301	250–312		
Crystallization	112	126–98	–19.7	–21.20

^a according to ASTM E 793-06

products, e.g. (Bu₄N)₂[CdBr₄]·2C₇H₈ [25] and [Cd{SSi(OBu^t)₃}(S₂CNC₄H₈)I][Bu₄N] [26] by just a small modification of the reaction system like a change of the solvent or quaternary salt used. Nevertheless, the reaction between [Cd{SSi(OBu^t)₃}]₂ and C₄H₈NCS₂NH₄, carried out in the toluene/water mixture in the presence (or without) of tetra-*n*-butylammonium bromide, yielded plate-like colorless crystals of [Cd{μ-SSi(OBu^t)₃}(S₂CNC₄H₈)]₂ **1**.

Molecule of **1** is electrically neutral centrosymmetric dimeric complex crystallizing in monoclinic system in *C2/c* space group. Each of its cadmium atoms is coordinated by four S atoms originating from one chelating dithiocarbamate- and two silanethiolato-rests. Both silanethiolate sulfur atoms act as bridges between two Cd atoms forming the planar central [2Cd–2S] ring. Because of the chelating character of dithiocarbamate ligands, the tetrahedral geometry at Cd atoms is severely distorted. Noticeable and favorable feature of **1** is the lack of additional intermolecular interactions within the crystal, as these can influence the melting point and volatility of the compound (Fig. 1).

**Fig. 8** Far infrared spectrum of the final product of decomposition of [Cd{μ-SSi(OBu^t)₃}(S₂CNC₄H₈)]₂ **1****Fig. 9** XRD pattern for the decomposition product of [Cd{μ-SSi(OBu^t)₃}(S₂CNC₄H₈)]₂

The thin film of the complex **1** was prepared via spin-coating on hydrophilic surface, i.e., native oxide-terminated Si(111), to examine nascent morphology of the thus obtained layer. The particle size and self-organization have been analyzed by AFM and TEM techniques. The AFM measurements performed in the tapping mode (Fig. 2) revealed that **1**, when spin-casted from THF, assembled into porous layers with the pore diameters ranging from 50 to 500 nm. The thickness of the film is 3 nm. TEM images revealed also the existence of small (ca. 3 nm) particles.

The chemical composition of the spin-coated layers was determined quantitatively by means of X-ray photoelectron spectroscopy (XPS). Figure 3 displays the XPS spectrum of **1** clearly showing the presence of O, S, Cd and Si signals.

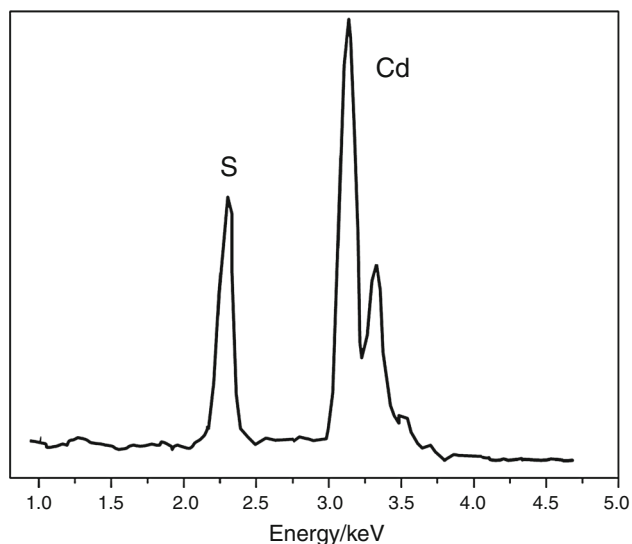


Fig. 10 EDS spectrum recorded for polycrystalline material obtained by pyrolysis of the complex $[\text{Cd}\{\mu\text{-SSi}(\text{O}i\text{Bu})_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]$

Thermal analysis and complementary techniques

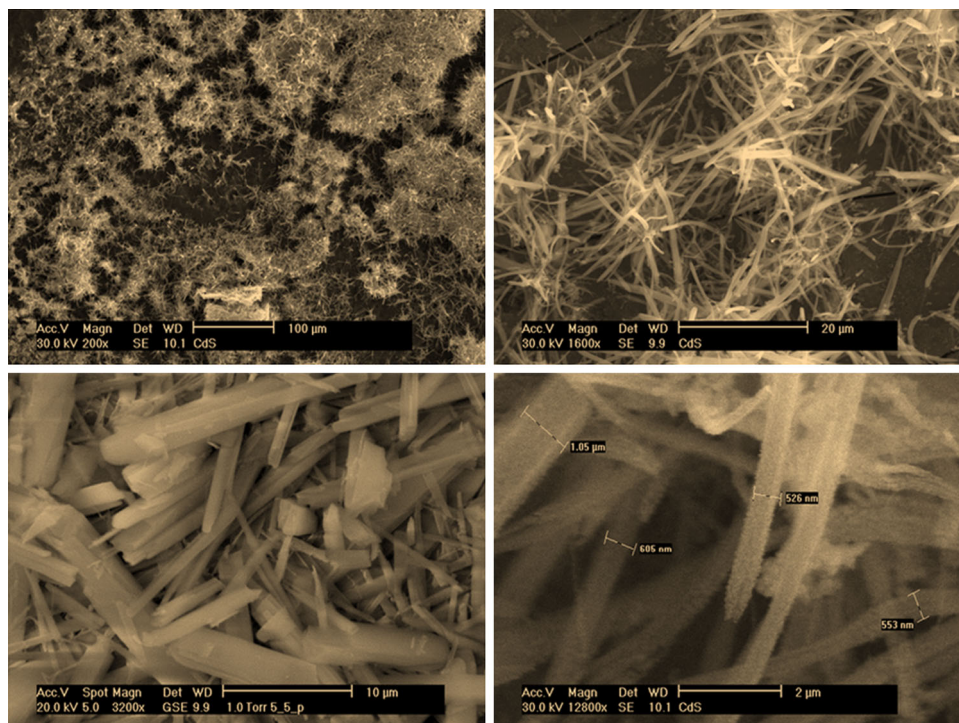
To assess the potential of $[\text{Cd}\{\mu\text{-SSi}(\text{O}i\text{Bu})_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]$ as a convenient source of cadmium sulfide, its thermal decomposition has been investigated by a combination of DSC, TG, and IR techniques. Figure 4 shows the TG and DTG curves of the investigated compound recorded at 10 K min^{-1} ; similar curves were obtained for other heating rates (2, 5, 15 and 20 K min^{-1}). Between 100 and $225 \text{ }^\circ\text{C}$,

the system loses around 4 % of its total mass, what most probably corresponds to that of the adsorbed solvent. Thermal decomposition of **1** starts at $229 \text{ }^\circ\text{C}$ that is somewhat characteristic for dimeric silanethiolate complexes of cadmium [19]. As shown in Fig. 4, thermal degradation of heteroleptic complex **1** proceeds in two steps (with DTG_{max} at 318.9 and $388 \text{ }^\circ\text{C}$). The decomposition of homoleptic cadmium(II) tri-*tert*-butoxysilanethiolate and heteroleptic $[\text{Cd}\{\mu\text{-SSi}(\text{O}i\text{Bu})_3\}(\text{S}_2\text{CNEt}_2)_2]$ [18] starts within the same temperature but proceeds in only one step. Therefore to obtain decomposition product of **1** the annealing should be carried up to at least $400 \text{ }^\circ\text{C}$, which is nearly $90 \text{ }^\circ\text{C}$ higher than that for $[\text{Cd}\{\text{SSi}(\text{O}i\text{Bu})_3\}_2]_2$ and $50 \text{ }^\circ\text{C}$ higher than that for $[\text{Cd}\{\mu\text{-SSi}(\text{O}i\text{Bu})_3\}(\text{S}_2\text{CNEt}_2)_2]$.

After melting at $227 \text{ }^\circ\text{C}$, $[\text{Cd}\{\mu\text{-SSi}(\text{O}i\text{Bu})_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]$ undergoes endothermic decomposition between 260 and $325 \text{ }^\circ\text{C}$. The DSC curve indicates two heat transfers, corresponding to the melting and decomposition of the investigated compound (Fig. 5).

Figure 6 shows TG-FTIR spectra recorded for products evolved during thermal decomposition of complex **1**. Two major groups of species may be identified related to $\text{S}_2\text{CNC}_4\text{H}_8$ and tri-*tert*-butoxysilyl substituents, respectively, with the latter, most probably undergoing further decomposition into gaseous products possessing both Si-OH ($\nu(\text{Si}-\text{O})$ 1075 cm^{-1}) and Si-O*Bu*' ($\nu(\text{C}-\text{O})$ 1190 cm^{-1}) fragments. The presence of bands arising from symmetric and asymmetric scissor-bending vibration modes characteristic for *tert*-butyl substituent (1392 and

Fig. 11 SEM images of CdS obtained using $[\text{Cd}\{\mu\text{-SSi}(\text{O}i\text{Bu})_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]$ as precursor



1369 cm^{-1}) as well as skeleton vibration of $-\text{Bu}'$ rest as a whole (1242 cm^{-1}) is noteworthy. In the FT-IR spectra of the off-gases, a small amount of ethyl isothiocyanate ($\text{C}_2\text{H}_5\text{NCS}$) with absorption bands at 2073 and 2051 cm^{-1} can also be seen (Fig. 7).

The introduction of dithio- substituents can thus modify the decomposition character, and the decomposition scheme of **1** can be tentatively described in Scheme 1.

This is in good agreement with data obtained from the TG experiment (Tables 2, 3)

The characterization of the decomposition product

The final product of decomposition process (obtained when the sample was heated to $410 \text{ }^\circ\text{C}$) is CdS, as confirmed by FIR ($\nu_{\text{Cd-S}}$ at 254 cm^{-1} , Fig. 8) and XRD analysis.

To assess the potential of $[\text{Cd}\{\mu\text{-SSi}(\text{O}i\text{Bu})_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]$ as a source of cadmium sulfide, we have also decomposed this compound using the pyrolysis deposition technique and obtained thin films of yellow product deposited on a glass substrate. The X-ray pattern of the residue indicated only the presence of α -CdS wurzite-type crystallites (Fig. 9). For characterization and qualitative analysis, the results were compared with standard data from the International Centre for Diffraction Data [22]. Additional EDS measurement revealed that the decomposition leads to CdS as the only deposited product (sulfur *K* line at 2.3076 keV; cadmium *L* line at 3.1315 keV as seen in Fig. 10).

Cadmium sulfide obtained by the thermal decomposition of **1** possesses an interesting morphology as shown in Fig. 11a–d. SEM images reveal that it consists of large quantity of structures which can be best described as “micro-noodles” of ca. 500 nm wide and several micrometers long. For CdS, no such data were yet reported. Similar shapes were observed, e.g., by O’Brien and coworkers in the case of NiS [27].

Conclusions

In conclusion, we confirmed our earlier observations that a reaction of dimeric bis(tri-*tert*-butoxysilanethiolato)cadmium(II) $[\text{Cd}\{\text{SSi}(\text{O}i\text{Bu})_3\}_2]$ with dithiocarbamate ammonium salts results in the formation of heteroleptic cadmium(II) complexes. The crystals of stable heteroleptic $[\text{Cd}\{\mu\text{-SSi}(\text{O}i\text{Bu})_3\}(\text{S}_2\text{CNC}_4\text{H}_8)_2]$ complex are formed of binuclear molecules lacking secondary intermolecular interactions. The thermal decomposition of **1** proceeds in two steps. As indicated by the TG experiments, the complex possesses sufficient volatility, and above ca. $300 \text{ }^\circ\text{C}$, undergoes thermal decomposition forming yellow crystalline deposits. The X-ray pattern of the residue indicates only

the presence of α -CdS. The most notable feature is an interesting and reproducible “micro-noodleslike” morphology of the thus obtained deposits. From the application perspective (thermal treatment), the complex fulfills the primary requirements necessary for a cadmium sulfide precursor.

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